


<b>Search Notes</b>  	<b>Application/Control No.</b>  10647350	<b>Applicant(s)/Patent Under Reexamination</b>  LEE ET AL.
	<b>Examiner</b>  Sandoval, Kristin D	<b>Art Unit</b>  2132

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Searched EAST, see attached search history	3/21/2007	KDS
Consulted Ben Lanier	3/21/2007	KDS
Searched EAST, see attached search history	9/14/2007	KDS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner